

APPLICANT FAX/SIMILE OF FORM PTO-144B REV 7-82	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY DOCKET NO. <b>SIW-024</b>	SERIAL NO. <b>To Be Assigned</b>
LIST OF PUBLICATIONS CITED BY APPLICANT (Use several sheets if necessary)		Applicant: <b>Masajirou INOUE et al.</b>	Pro <b>4460</b>
		FILING DATE <b>Herewith</b>	GROUP <b>1</b>

U.S. PATENT DOCUMENTS

## FOREIGN PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION
							YES
AC	A1	Hei 11-129396	05/99	Japan	—	—	Abst
	A2	Hei 11-179755	07/99	Japan	—	—	Abst
	A3	Hei 11-309746	11/99	Japan	—	—	Abst
	A4	Hei 11-309747	11/99	Japan	—	—	Abst
	A5	2000-033630	02/00	Japan	—	—	Abst
AC	A6	2000-133288	05/00	Japan	—	—	Abst

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DOCUMENT NUMBER		DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION
				—	—	Yes      No
RD	B1	60-257528	12/85	Japan	—	Abstr.
RD	B2	11-40592	02/99	Japan	—	Abstr.
RD	B3	11-129396	05/99	Japan	—	Abstr.

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**Examiner**

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Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.